Search Notes		
	 	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/520,010	KAWAMURA ET AL.
Examiner	Art Unit
Thinh T. Nguyen	2818

SEARCHED					
Class	Subclass	Date	Examiner		
257	414	5/26/2006	TTN		
257	40	5/26/2006	TTN		
257	72	5/26/2006	TTN		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
EAST	PUB	5/26/2006	TTN	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	5/26/2006	TTN	